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April 13th, 2017

RE: LFPCN41259

To: Our Valued Customers.

From: **Littelfuse Product Management Team**

Subject: **TVS Diode LKTAK series alternative assembly line approval**

In order to support growing demand, and maintain operational excellence, we are expanding our packaging capacity of LTKAK product. Littelfuse would like to notify you of a newly approved backend assembly line for LTKAK series TVS Diode products. The new approved 2<sup>nd</sup> production line is located in Littelfuse Semiconductor Wuxi China. Both current assembly line and newly approved assembly line will support each other for better delivery.

There are no changes on FIT, form or function of the finished product.

Qualification efforts are complete and the new factories are online for immediate shipments. Please see the attached documentation for change detail and affected part numbers. All affected products have been fully qualified in accordance with established performance and reliability criteria. The attached pages summarize the qualification results. Full qualification data and/or samples will be available upon request.

**Form, fit, function changes:** None  
**Part number changes:** None  
**Effective date:** July 1<sup>st</sup>, 2017 or sooner  
**Replacement products:** N/A  
**Last time buy:** N/A

This notification is for your information and acknowledgement. If you have any other questions or concerns, please contact Meng Wang, Product Manager. We highly value your business and look forward to assisting you whenever possible.

Best Regards

Meng Wang ( Rex Wang)

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## Product Qualification Report

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To: Those who may concern  
From: Changjun Tang, TVS Product Engineer, Littelfuse.  
Date: April 10<sup>th</sup>, 2017  
Subject: TVS Diode LTKAK Series Alternative Assembly Line Qualification

### Purpose:

This report is to inform the successful qualification test results associated with LTKAK6/LTKAK10 product series in Wuxi In-house plant.

### 1. Qualification Types (Test Vehicle)

Product Series	Representative Test Sample Part Numbers	Lot Type	Assy Lot	Assembly Location
LTKAK	LTKAK6-066C	Control Lot	7A06ZPEE	Outsource
	LTKAK6-066C	Test Lot	7A14ZPEE	Wuxi In-house
	LTKAK6-076C	Test Lot	7A13ZPEE	Wuxi In-house
	LTKAK10-076C	Control Lot	7A09ZPEE	Outsource
	LTKAK10-076C	Test Lot	7A08ZPEE	Wuxi In-house
	LTKAK10-076C	Test Lot	7A10ZPEE	Wuxi In-house
	LTKAK10-076C	Test Lot	7A11ZPEE	Wuxi In-house

## 2. Qualification Test Items and Result Summary:

Test Category	Description	Part Number	Lot Number	Samples Qty	Littelfuse ETR#	Contents/Conditions	Result
Reliability	Pre-conditioning	LTKAK6-066C	7A06ZPEE	197	92945	24hrs 125°C bake/168hrs 85%RH, 85°C sock/3 times 260°C peak temperature reflow	0 failure post test
		LTKAK6-066C	7A14ZPEE	197	92945		
		LTKAK6-076C	7A13ZPEE	197	92945		
		LTKAK10-076C	7A09ZPEE	197	93157		
		LTKAK10-076C	7A08ZPEE	197	93157		
		LTKAK10-076C	7A10ZPEE	197	93159		
	DC Blocking (HTRB)	LTKAK10-076C	7A11ZPEE	197	93159	125°C, 100% rated VR, 1008hrs	0 failure at 1008 hours
		LTKAK6-066C	7A06ZPEE	77	92945		
		LTKAK6-066C	7A14ZPEE	77	92945		
		LTKAK6-076C	7A13ZPEE	77	92945		
		LTKAK10-076C	7A09ZPEE	77	93157		
		LTKAK10-076C	7A08ZPEE	77	93157		
	Biased Temp&Humidity (H3TRB)	LTKAK10-076C	7A10ZPEE	77	93159	85°C/85% RH with device reverse biased at 100% of rated VR	0 failure at 1008 hours
		LTKAK6-066C	7A06ZPEE	30	92945		
		LTKAK6-066C	7A14ZPEE	30	92945		
		LTKAK6-076C	7A13ZPEE	30	92945		
		LTKAK10-076C	7A09ZPEE	30	93157		
		LTKAK10-076C	7A08ZPEE	30	93157		
	Temperature Cycling	LTKAK10-076C	7A11ZPEE	30	93159	-55°C&150°C, 15 minutes dwell 500 cycles	0 failure at 500 cycles
		LTKAK6-066C	7A06ZPEE	30	92945		
		LTKAK6-066C	7A14ZPEE	30	92945		
		LTKAK6-076C	7A13ZPEE	30	92945		
		LTKAK10-076C	7A09ZPEE	30	93157		
		LTKAK10-076C	7A08ZPEE	30	93157		
	High Temperature Storage Life (HTSL)	LTKAK10-076C	7A10ZPEE	30	93159	Ta=150°C, 1008hrs	0 failure at 1008 hours
		LTKAK6-066C	7A06ZPEE	30	92945		
		LTKAK6-066C	7A14ZPEE	30	92945		
		LTKAK6-076C	7A13ZPEE	30	92945		
		LTKAK10-076C	7A09ZPEE	30	93157		
		LTKAK10-076C	7A08ZPEE	30	93157		
	Resistance to Solder Heat	LTKAK10-076C	7A11ZPEE	30	93159	260±5°C, 10±1s/3 times	0 failure after RSH
		LTKAK6-066C	7A06ZPEE	30	92945		
		LTKAK6-066C	7A14ZPEE	30	92945		
LTKAK6-076C		7A13ZPEE	30	92945			
LTKAK10-076C		7A09ZPEE	30	93157			
LTKAK10-076C		7A08ZPEE	30	93157			

Test Category	Description	Part Number	Lot Number	Samples Qty	Littelfuse ETR#	Contents/Conditions	Result
Parametric	Electrical Parameters	LTKAK6-066C	7A06ZPEE	217	92945	VBR,IR	100% meet published spec
		LTKAK6-066C	7A14ZPEE	217	92945		
		LTKAK6-076C	7A13ZPEE	217	92945		
		LTKAK10-076C	7A09ZPEE	217	93157		
		LTKAK10-076C	7A08ZPEE	217	93157		
		LTKAK10-076C	7A10ZPEE	217	93159		
	8/20us Surge Out	LTKAK6-066C	7A06ZPEE	10	93009	+/- 1hit, from 100% rated IPP, 0.1IPP step	100% passing at 1.1xRated IPP
		LTKAK6-066C	7A14ZPEE	10	93009		
		LTKAK6-076C	7A13ZPEE	10	93009		
		LTKAK10-076C	7A09ZPEE	10	93161		
		LTKAK10-076C	7A08ZPEE	10	93161		
		LTKAK10-076C	7A10ZPEE	10	93161		
	10/350us Surge Out	LTKAK6-066C	7A06ZPEE	10	93008	+/- 1hit, from 100% rated Minimum IPP, 0.1IPP step	100% passing at 1.1xRated IPP
		LTKAK6-066C	7A14ZPEE	10	93008		
		LTKAK6-076C	7A13ZPEE	10	93008		
		LTKAK10-076C	7A09ZPEE	10	93160		
		LTKAK10-076C	7A08ZPEE	10	93160		
		LTKAK10-076C	7A10ZPEE	10	93160		
	8/20us Surge Life	LTKAK6-066C	7A06ZPEE	10	93009	100% rated IPP, Continually surge to 30 hits	0 failure after surge life
		LTKAK6-066C	7A14ZPEE	10	93009		
		LTKAK6-076C	7A13ZPEE	10	93009		
		LTKAK10-076C	7A09ZPEE	10	93161		
		LTKAK10-076C	7A08ZPEE	10	93161		
		LTKAK10-076C	7A10ZPEE	10	93161		
	10/350us Surge Life	LTKAK6-066C	7A06ZPEE	10	93008	100% rated IPP, Continually surge to 30 hits	0 failure after surge life
		LTKAK6-066C	7A14ZPEE	10	93008		
		LTKAK6-076C	7A13ZPEE	10	93008		
		LTKAK10-076C	7A09ZPEE	10	93160		
		LTKAK10-076C	7A08ZPEE	10	93160		
		LTKAK10-076C	7A10ZPEE	10	93160		

### 3. MTBF Calculation

Estimate of Failure Rate, MTBF, FITS for a Given Operation Temperature (**See note**)

Temp °C	% FR/khrs	MTBF (K)	FITS
30	0.00013	784196.0	1.28
60	0.00400	24972.6	40.04
80	0.02879	3473.6	287.88
100	0.16752	596.9	1675.22
125	1.18054	84.7	11805.44

Note: The **Mean-Time-Between-Failure** (MTBF) in hours and the percent failure rate per 1000 hours (%FR/khr) are computed at a 60% confidence level using the chi square method and the Arrhenius derating model for various junction operating temperatures. For the calculations, a value of 1 eV was used for the activation energy.

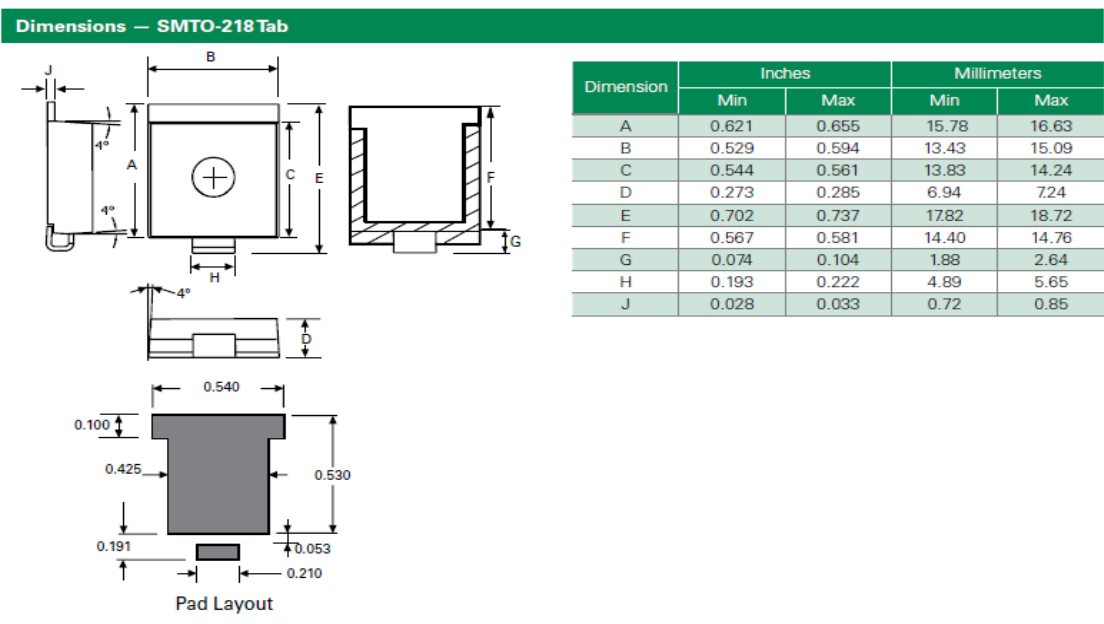
#### 4. FAB Process & Material Differences/Changes:

- 4.1 For LTKAK10 series, optimize the chip design
- 4.2 No significant changes in the assembly and process method for all LTKAK series.

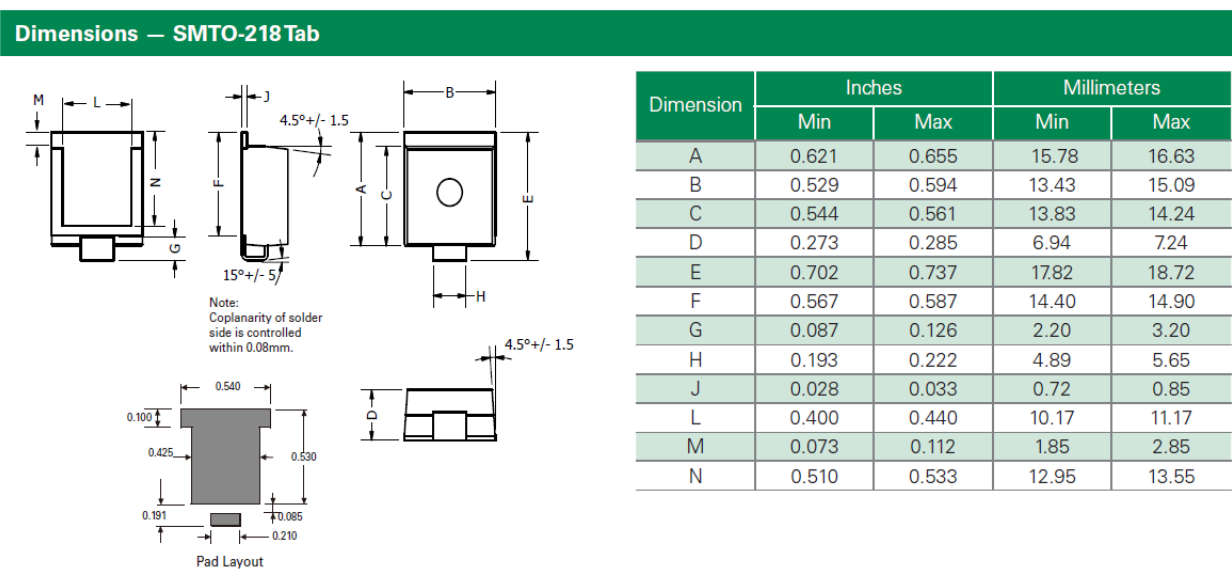
#### 5. Physical Differences/Changes

- 5.1 Add detail dimension specification of Heatsink(L,M,N dimension)
- 5.2 Correct G dimension

Current physical dimensions on published datasheet:



Future physical dimensions in published datasheet:



## 6. Electrical Characteristic Change:

### 6.1 Update LTKAK6 series 10/350us Surge I<sub>PP</sub>

Current:

Electrical Characteristics (T <sub>a</sub> =25°C unless otherwise noted)												
Part Numbers	Standoff Voltage (V <sub>SO</sub> ) (V)	Max. Reverse Leakage (I <sub>R</sub> ) @ V <sub>SO</sub> (μA)	Reverse Breakdown Voltage (V <sub>BR</sub> ) @ I <sub>T</sub>		Test Current I <sub>T</sub> (mA)	Max. Clamping Voltage V <sub>CL</sub> @ Peak Pulse Current (I <sub>PP</sub> )				Max. Temp Coefficient of V <sub>BR</sub> (%/°C)	Max. Capacitance 0 Bias 10kHz (nF)	
			Min Volts	Max Volts		V <sub>CL</sub> Volts	I <sub>PP</sub> (8/20μS) (A)		I <sub>PP</sub> (10/350μS) (A)			
							min	typ	min			typ
LTKAK6-058C	58	10	64	70	10	110	6,000	-	1,000	-	0.1	6.5
LTKAK6-066C	66	10	72	80	10	120	6,000	-	600	-	0.1	5.5
LTKAK6-076C	76	10	85	95	10	140	6,000	9,500	1,100	-	0.1	4.5



Future:

Electrical Characteristics (T <sub>a</sub> =25°C unless otherwise noted)									
Part Numbers	Standoff Voltage (V <sub>SO</sub> ) (V)	Max. Reverse Leakage (I <sub>R</sub> ) @ V <sub>SO</sub> (μA)	Reverse Breakdown Voltage (V <sub>BR</sub> ) @ I <sub>T</sub>		Test Current I <sub>T</sub> (mA)	Max. Clamping Voltage V <sub>C</sub> @ I <sub>PP</sub> (Volts)	Max. Temp Coefficient of V <sub>BR</sub> (%/°C)	Max. Capacitance 0 Bias 10kHz (nF)	
			Min Volts	Max Volts					
LTKAK6-058C	58	10	64	70	10	110	0.1	6.5	
LTKAK6-066C	66	10	72	80	10	120	0.1	5.5	
LTKAK6-076C	76	10	85	95	10	140	0.1	4.5	

Note: Using 8/20μS wave shaped defined in IEC 61000-4-5.

Surge Ratings				
Part Numbers	Max. Peak Pulse Current (I <sub>PP</sub> )			
	(8/20μS) (A)	(10/350μS) (A)	(10/1000μS) (A)	
	min	min	min	
LTKAK6-058C	6,000	900	430	
LTKAK6-066C	6,000	900	430	
LTKAK6-076C	6,000	900	430	

### 6.1 Update LTKAK6 series 10/350us Surge I<sub>PP</sub>

Current:

Electrical Characteristics												
Part Numbers	Standoff Voltage (V <sub>SO</sub> ) (V)	Max. Reverse Leakage (I <sub>R</sub> ) @ V <sub>SO</sub> (μA)	Reverse Breakdown Voltage (V <sub>BR</sub> ) @ I <sub>T</sub>		Test Current I <sub>T</sub> (mA)	Max. Clamping Voltage V <sub>CL</sub> @ Peak Pulse Current (I <sub>PP</sub> )				Max. Temp Coefficient of V <sub>BR</sub> (%/°C)	Max. Capacitance 0 Bias 10kHz (nF)	
			Min Volts	Max Volts		V <sub>CL</sub> Volts	I <sub>PP</sub> (8/20μS) (A)		I <sub>PP</sub> (10/350μS) (A)			
							min	typ	min			typ
LTKAK10-058C	58	10	64	70	10	110	10,000	-	-	-	0.1	8.5
LTKAK10-066C	66	10	72	80	10	120	10,000	13,000	800	-	0.1	7.5
LTKAK10-076C	76	10	85	95	10	140	10,000	12,000	450	-	0.1	6.5



**Future:**

Electrical Characteristics											
Part Numbers	Standoff Voltage (V <sub>SO</sub> ) (V)	Max. Reverse Leakage (I <sub>R</sub> ) @ V <sub>SO</sub> (μA)	Reverse Breakdown Voltage (V <sub>BR</sub> ) @ I <sub>T</sub>		Test Current I <sub>T</sub> (mA)	Max. Clamping Voltage V <sub>CL</sub> @ Peak Pulse Current (I <sub>PP</sub> )			Max. Temp Coefficient of V <sub>BR</sub> (%/°C)	Max. Capacitance 0 Bias 10kHz (nF)	
			Min Volts	Max Volts		V <sub>CL</sub> Volts	I <sub>PP</sub> (A)				
							(8/20μS) min	(10/350μS) typ			
LTKAK10-058C	58	10	64	70	10	110	10,000	1,400	1,700	0.1	8.5
LTKAK10-066C	66	10	72	80	10	120	10,000	950	1,100	0.1	7.5
LTKAK10-076C	76	10	85	95	10	140	10,000	950	1,100	0.1	6.5
LTKAK10-080C	80	10	89	100	10	150	10,000	900	1,100	0.1	6.5
LTKAK10-086C	86	10	95	105	10	157	10,000	900	1,100	0.1	6.5

**7. Conclusion**

According to the above qualification test results, Littelfuse concluded that LTKAK product series which manufactured in LF Wuxi in-house plant have passed all Reliability Test at WTC Lab.

Littelfuse Wuxi in-house will be ready to start mass production.

**Supplement –**

Marking demonstration for Wuxi made parts and our current subcontractor manufacturing made parts

Wuxi parts use Character and subcontractor manufacturing use number

